# imall

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### Test Procedure for the NCP160MXTBGEVB Evaluation Board

There is a collection test procedures for NCP160 demoboards. This paper offers some helpful test configuration for first contact with ONSEMI NCP160 LDO.

#### 1. QUIESCENT CURRENT

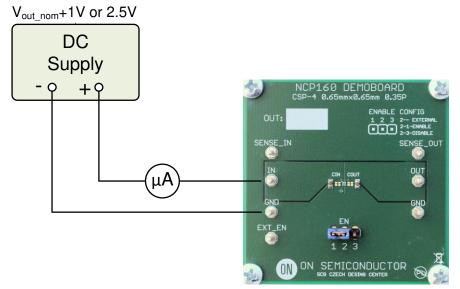


Figure 1: Test configuration for measurement I<sub>0</sub>, Quiescent Current

- 1. Connect circuit as shown figure on 1
- 2. Apply voltage at V<sub>Input.</sub> Default test V<sub>input</sub> is V<sub>out\_nom</sub>+1 V or 2.5 V whichever is greater
- 3. Value shown  $\mu A$  meter is measured quiescent current.
- 4. Measurement is finished. Disconnect supply voltage.

\*Note – Be carefully if any device is connected on output, because leakage current can affect measurement accuracy.

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#### 2. LOAD REGULATION

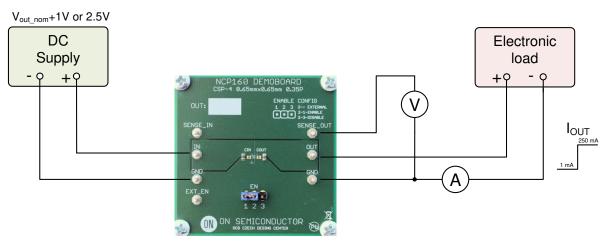


Figure 2: Test configuration for measurement REG<sub>LOAD</sub>, Load Regulation

- 1. Connect circuit as shown figure on 2
- 2. Apply voltage at V<sub>Input.</sub> Default test V<sub>input</sub> is V<sub>out\_nom</sub>+1 V or 2.5 V whichever is greater
- 3. Set minimal required current  $I_1$ , e.g. 1 mA, and switch load ON.
- 4. Note the value V1 from voltmeter Vo.
- 5. Switch load OFF and set maximal required current I2, e.g. 250 mA and switch load ON.
- 6. Note the value V2 from voltmeter Vo.
- 7. Load regulation is obtained via following formula:  $REG_{LOAD}=(V_1-V_2)$ , [V]
- 8. Measurement is finished. Disconnect supply voltage.

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#### 3. LINE REGULATION

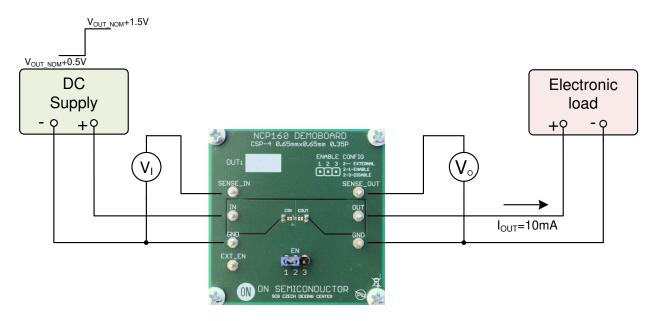


Figure 3: Test configuration for measurement  $\text{REG}_{\text{LINE}},$  Line Regulation

- 1. Connect circuit as shown on figure 3
- 2. Set load to the required current e.g. 10 mA
- 3. Set minimal input voltage  $V_{11},\,V_{\text{OUT}\_\text{NOM}}\text{+}1V$  or 2.5V whichever is greater
- 4. Note the value  $V_{l1}$  and  $V_{O1}$ .
- 5. Set maximal input voltage  $V_{12} = 5.5 V$
- 6. Note the value  $V_{12}$  and  $V_{02}$ .
- 7. Load regulation is obtained via following formula:  $REG_{LINE} = (V_{O1} V_{O2})/(V_{11} V_{12})$ , [V/V]
- 8. Measurement is finished. Disconnect supply voltage.

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#### 4. ENABLE START-UP

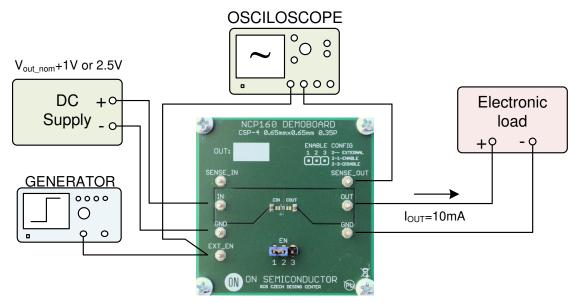


Figure 4: Test configuration for measurement enables response

- 1. Connect circuit as shown on figure 4
- 2. Set generator to SQUARE PULSE,  $0.9 \le AMPLITUDE \le V_{IN}$ , FREQUENCY=10Hz, DUTY=10%
- 3. Apply voltage at  $V_{Input}$ . Default test  $V_{input}$  is  $V_{out_nom}$ +1 V or 2.5 V whichever is greater
- 4. Set required I<sub>OUT</sub>, e.g. 10 mA
- 5. Connect oscilloscope to EN signal and VOUTPUT.
- 6. Watch enable response of the regulator after asserting EN pin.
- 7. Measurement is finished. Disconnect supply voltage.